

SIGC18T60NC

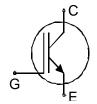
IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology
- 100µm chip
- positive temperature coefficient
- easy paralleling

This chip is used for:

IGBT Modules



Applications:

• drives

| Chip Type | V _{CE} | I _{Cn} | Die Size | Package | Ordering Code | |
|-------------|-----------------|-----------------|---------------------------|----------------|---------------|--|
| SIGC18T60NC | 600V | 20A | 4.3 x 4.3 mm ² | sawn on foil | Q67050-A4139- | |
| 0100101001 | | 20/1 | 4.0 X 4.0 IIIII | Jawii dii idii | A001 | |

MECHANICAL PARAMETER:

| Raster size | 4.3 x 4.3 | | | |
|---------------------------------|---|-----|--|--|
| Area total / active | 18.49 / 14.3 | | | |
| Emitter pad size | 2.48 x 2.98 | | | |
| Gate pad size | 0.7 x 1.08 | | | |
| Thickness | 100 | μm | | |
| Wafer size | 150 | mm | | |
| Flat position | 270 | deg | | |
| Max.possible chips per wafer | 796 | | | |
| Passivation frontside | Photoimide | | | |
| Emitter metallization | 3200 nm Al Si 1% | | | |
| Collector metallization | 1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding | | | |
| Die bond | electrically conductive glue or solder | | | |
| Wire bond | AI, ≤500μm | | | |
| Reject Ink Dot Size | Ø 0.65mm; max 1.2mm | | | |
| Recommended Storage Environment | store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C | | | |



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MAXIMUM RATINGS:

| Parameter | Symbol | Value | Unit |
|---|--------------------|------------------|------|
| Collector-emitter voltage, T _j =25 °C | V _{CE} | 600 | V |
| DC collector current, limited by T _{jmax} | I _C | 1) | А |
| Pulsed collector current, t _p limited by T _{jmax} | I _{cpuls} | 60 | Α |
| Gate emitter voltage | V _{GE} | ±20 | V |
| Operating junction and storage temperature | T_j , T_{stg} | -55 + 150 | °C |

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

| Parameter | Symbol | Conditions | Value | | | Unit |
|--------------------------------------|----------------------|--|-------|------|------|------|
| Tarameter | | Conditions | min. | typ. | max. | 01 |
| Collector-emitter breakdown voltage | V _{(BR)CES} | V_{GE} =0V, I_{C} =1mA | 600 | | | |
| Collector-emitter saturation voltage | V _{CE(sat)} | V_{GE} =15V, I_{C} =20A | 1.7 | 2.0 | 2.5 | V |
| Gate-emitter threshold voltage | V _{GE(th)} | I_C =0.5mA, V_{GE} = V_{CE} | 4.5 | 5.5 | 6.5 | |
| Zero gate voltage collector current | I _{CES} | V _{CE} =600V, V _{GE} =0V | | | 70 | μA |
| Gate-emitter leakage current | I _{GES} | V _{CE} =0V, V _{GE} =20V | | | 120 | nA |

DYNAMIC CHARACTERISTICS (tested at component):

| Parameter | Symbol | Conditions | Value | | | Unit |
|------------------------------|--------|----------------------|-------|------|------|-------|
| raiailletei | | | min. | typ. | max. | Oilit |
| Input capacitance | Ciss | V _{CE} =25V | - | 900 | - | pF |
| Output capacitance | Coss | V _{GE} =0V | - | tbd | - | |
| Reverse transfer capacitance | Crss | f=1MHz | - | 80 | - | |

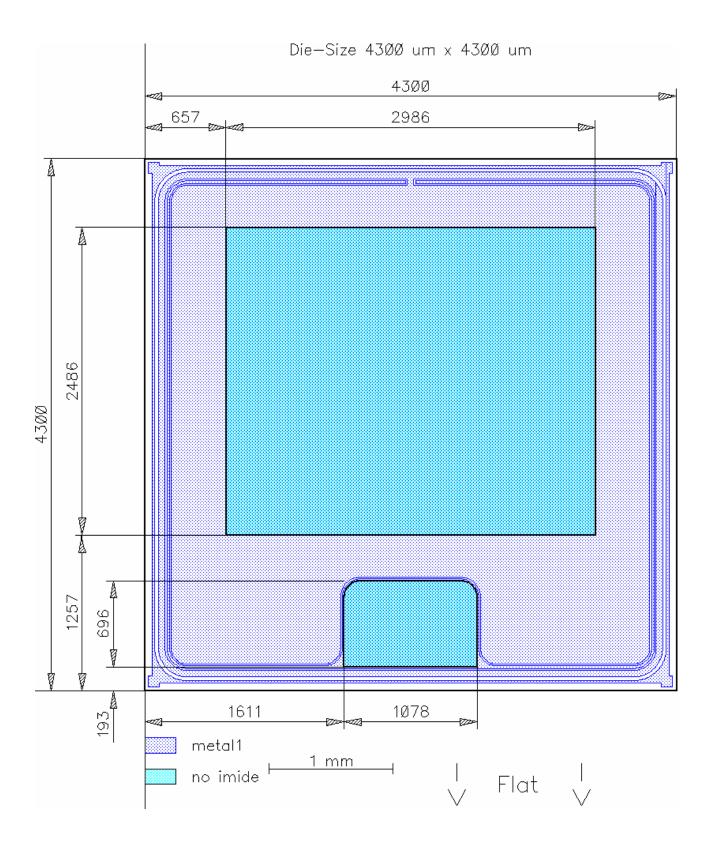
SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

| Parameter | Symbol | Conditions 1) | Value | | | Unit |
|---------------------|--------------|--|-------|------|------|------|
| - arameter | Symbol | Conditions | min. | typ. | max. | |
| Turn-on delay time | $t_{d(on)}$ | $T_{\rm j}$ =125°C $V_{\rm CC}$ =300V | - | 21 | - | ns |
| Rise time | t_{r} | I _C =20A | - | 8 | - | |
| Turn-off delay time | $t_{d(off)}$ | $V_{\text{GE}} = \pm 15 \text{V}$ $R_{\text{G}} = 13 \Omega$ | - | 110 | - | |
| Fall time | t_{f} | / NG - 1 032 | - | 25 | - | |

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





SIGC18T60NC

FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

FS 20 R06 XL4

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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